

规格书编号

**SPEC NO:** 

# 产品规格书 SPECIFICATION

CUSTOMER 客 户:							
PRODUCT 产品:	SAW FILTER						
MODEL NO 型 号:	HDF49A F11						
PREPARED 编 制:	CHECKED 审 核	:					
APPROVED 批准:	DATE 日期:	2004-9-26					
客户确认 CUSTOMER RECEIVED:							
审核 CHECKED	批准 APPROVED	日期 DATE					
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# 无锡市好达电子有限公司 Shoulder Electronics Limited



SAW FILTER HDF49A F11

# 更改历史记录 History Record

更改日期 Date	规格书编号 Spec. No.	产品型号 Part No.	客户产品型号 Customer No.	更改内容描述 Modify Content	备注 Remark



# 1. SCOPE

**SAW FILTER** 

This specification shall cover the characteristics of SAW filter With F49A used for the E-amps/adc.

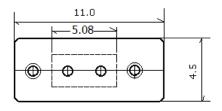
# 2. ELECTRICAL SPECIFICATION

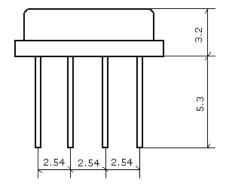
DC Voltage VDC	10V
AC Voltage Vpp	10V50Hz/60Hz
Operation temperature	-40°C to +85°C
Storage temperature	-45°C to +85°C
RF Power Dissipation	0dBm

#### 2.2 Electronic Characteristics

Туре	3dB passband (MHz)	Insertion-l oss MAX(dB)	Stop-band Atten. MIN(dB)	Loop-loss MIN(dB)	Out-band Atten. (dB)	Impedance (Ω)
HD F49A	49.67~ 49.99	4	30	42	30	50/50

## 3. DIMENSION



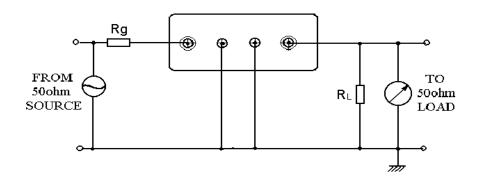




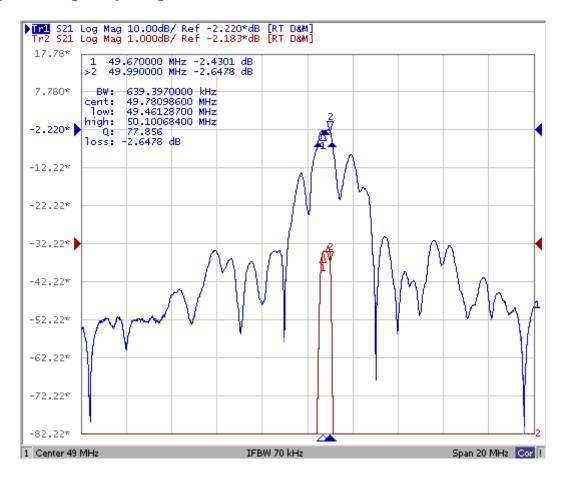


## 4.TEST CIRCUIT

**SAW FILTER** 



# **5. Typical Frequency Response**



### 6. ENVIRONMENTAL CHARACTERISTICS

6-1 High temperature exposure

Subject the device to +85°C for 16 hours. Then release the filter into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 2.2.

6-2 Low temperature exposure



SAW FILTER HDF49A F11

Subject the device to  $-40^{\circ}$ C for 16 hours. Then release the device into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 2.2.

#### 6-3 Temperature cycling

Subject the device to a low temperature of  $-40^{\circ}$ C for 30 minutes. Following by a high temperature of  $+85^{\circ}$ C for 30 Minutes. Then release the device into the room conditions for 24 hours prior to the measurement. It shall meet the specifications in 2.2.

#### 6-4 Resistance to solder heat

Dip the device terminals no closer than 1.5mm into the solder bath at  $260^{\circ}$ C  $\pm 10^{\circ}$ C for  $10\pm 1$  sec. Then release the device into the room conditions for 4 hours. The device shall meet the specifications in 2.2.

#### 6-5 Solderability

Subject the device terminals into the solder bath at  $245^{\circ}$ C  $\pm 5^{\circ}$ C for 5s, More than 95% area of the terminals must be covered with new solder. It shall meet the specifications in 2.2.

#### 6-6 Mechanical shock

Drop the device randomly onto the concrete floor from the height of 1m 3 times. the device shall fulfill the specifications in 2.2.

#### 6-7 Vibration

Subject the device to the vibration for 1 hour each in x,y and z axes with the amplitude of 1.5 mm at 10 to 55 Hz. The device shall fulfill the specifications in 2.2.

#### 7. REMARK

#### 7.1 Static voltage

Static voltage between signal load & ground may cause deterioration &destruction of the component. Please avoid static voltage.

#### 7.2 Ultrasonic cleaning

Ultrasonic vibration may cause deterioration & destruction of the component. Please avoid ultrasonic cleaning

#### 7.3 Soldering

Only leads of component may be solded. Please avoid soldering another part of component.